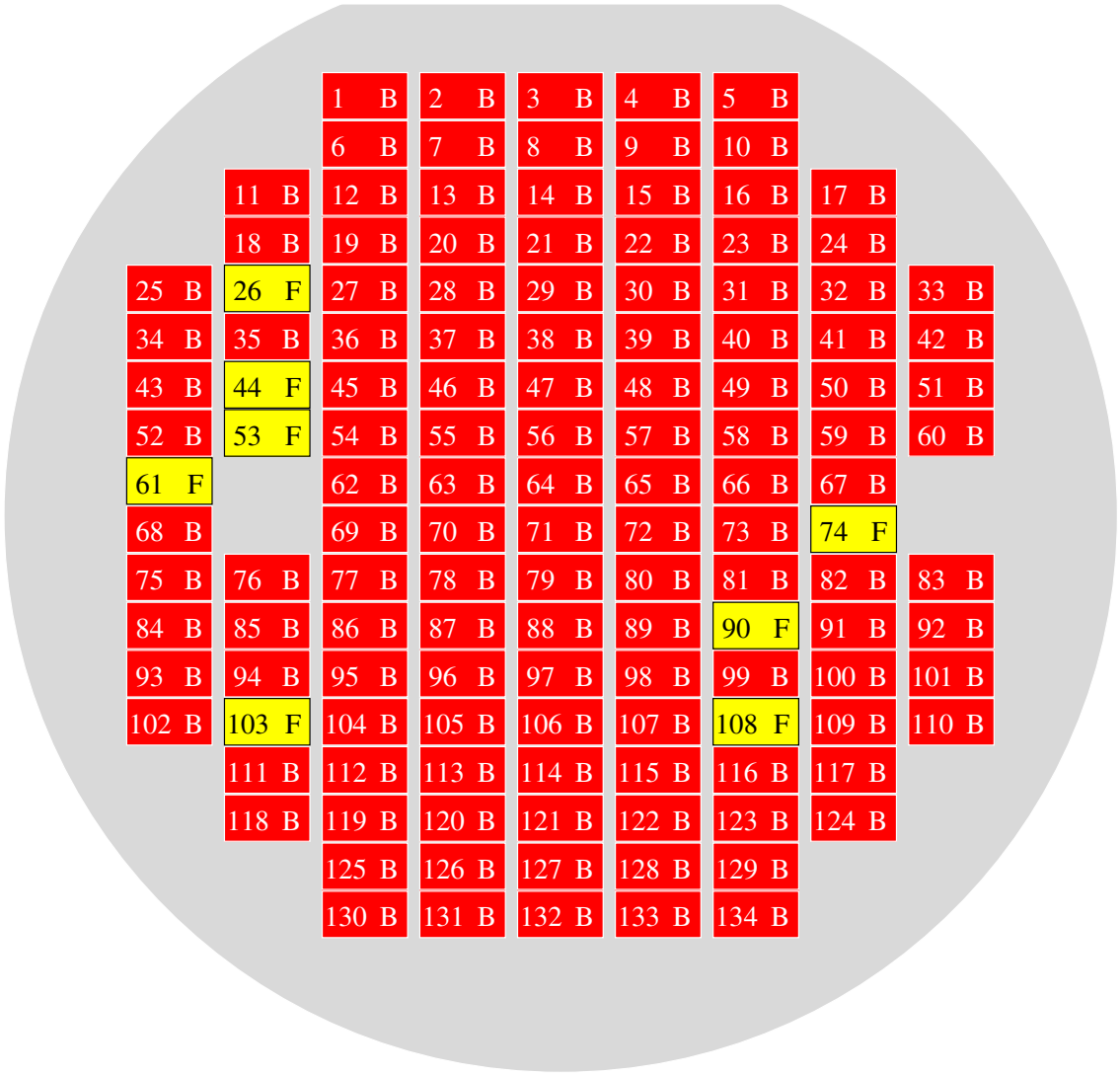
Die quality map for wafer 216 s/n: 21316-15-06

Date: 10/22/99



# B	Bad die
# F	Fair die
# G	Good die
# N	No info
# *	Manually tagged